



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: Walter Hirt et al.

SERIAL NO.: 09/902,553

ART UNIT: 2661

FILED: 07/10/2001

EXAMINER: Stephen CHIN

TITLE: APPARATUS AND METHOD FOR DETERMINING THE QUALITY
OF A DIGITAL SIGNAL

ATTORNEY DOCKET NO.: CH920000038US1

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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

In accordance with the duty of disclosure, Applicants call to the attention of the Examiner the list of documents on the attached forms PTO-1449 (Substitute). To assist the Examiner, also enclosed is a copy of the European Search Report for the corresponding application in Europe. It is respectfully requested that the Examiner consider these documents, and make them of record.

Respectfully submitted,

David Aker

12/18/2003

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Date

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I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

December 18, 2003

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INFORMATION DISCLOSURE CITATION FORM FOR PATENT APPLICATION (FORM PTO-1449) (Substitute)		Docket No.: CH920000038US1 Applicant(s): Walter Hirt et al. Filing Date: 07/10/01		Serial No.: 09/902,553 Group: 2661		
U.S. PATENTS						
Initials	Patent Number	Issue Date	Name	Class	Sub-class	Filing date
	5,280,637	01/1994	Larosa et al			
RECEIVED DEC 29 2003 Technology Center 2000						
FOREIGN PATENT DOCUMENTS						
Initials	Document Number	Date	Country	Name		Translation? Yes/No/n/a
	0289384 WO99/39216 05-235910 05-102953 2001-289892 05-75653 07-177151	11/1988 8/1999 09/1993 04/1993 10/2001 03/1993 07/1995	Europe PCT Japan Japan Japan Japan Japan	Journeau Wilstrup et al. Takahashi et al. Seki et al. Watanabe et al. McCabe Ito		cls abs abs abs abs abs abs
OTHER DOCUMENTS (Title, Author, Date, Pages, Etc., if known)						
Examiner's Signature:				Date Considered:		
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INFORMATION DISCLOSURE CITATION FORM FOR PATENT APPLICATION (FORM PTO-1449) (Substitute)		Docket No.: CH920000038US1	Serial No.: 09/902,553
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U.S. PATENTS

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FOREIGN PATENT DOCUMENTS

Initials	Document Number	Date	Country	Name	Translation? Yes/No/n/a
	62-12216	01/1987	Japan	Fujita	abs
	62-131637	06/1987	Japan	Kameyama et al.	abs
	53-15175	02/1978	Japan	Miki et al.	abs
	59-158657	09/1984	Japan	Tanaka et al.	abs
	59-171230	09/1984	Japan	Fujino	abs
	59-171233	09/1984	Japan	Fujino	abs

OTHER DOCUMENTS (Title, Author, Date, Pages, Etc., if known)

Examiner's Signature:

Date Considered:

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